

<b>Notice of References Cited</b>	Application/Control No. 10/524,521	Applicant(s)/Patent Under Reexamination TERADA ET AL.	
	Examiner MUHAMMAD N. EDUN	Art Unit 2627	Page 1 of 1

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*	A	US-7,031,239	04-2006	Takahashi et al.	369/47.14
*	B	US-2006/0053249	03-2006	Yamaki et al.	711/112
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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